

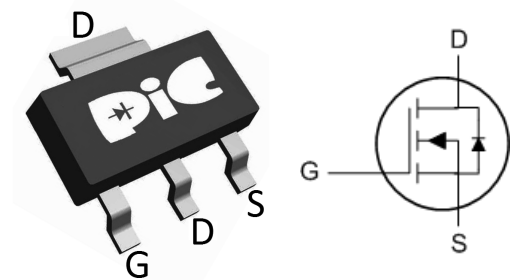
➤ General Description

This PAN03TB20QB N-Channel enhancement mode power field effect transistor is the high density trench technology and this advanced technology can provide excellent $R_{ds(On)}$ performance and efficiency for power switching and load switching application., this device also comply with the RoHS and Green Product requirement with full function reliability approved.

➤ Feature

- Green Device Available
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- Advanced high cell density Trench technology
- SOT-223 package design

➤ SOT-223



➤ Application

- Motor and Load Control
- Power Management in White LED System
- Push Pull Converter
- LCD TV Inverter & AD/DC Inverter Systems.

➤ Absolute Maximum Ratings

| Parameter | Symbol | Rating | Units |
|-----------------------------------------------------------------|-----------------------|------------|--------------|
| Drain-Source Voltage | V_{DS} | 200 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | V |
| Continuous Drain Current, V_{GS} @ 10V ₁ | $I_D@T_C=25^\circ C$ | 1.5 | A |
| Continuous Drain Current, V_{GS} @ 10V ₁ | $I_D@T_C=100^\circ C$ | 1.3 | A |
| Pulsed Drain Current ₂ | I_{DM} | 8 | A |
| Single Pulse Avalanche Energy ₃ | EAS | 8 | mJ |
| Avalanche Current | I_{AS} | 4 | A |
| Total Power Dissipation ₄ | $P_D@T_C=25^\circ C$ | 42 | W |
| Storage Temperature Range | T_{STG} | -55 to 150 | $^\circ C$ |
| Operating Junction Temperature Range | T_J | -55 to 150 | $^\circ C$ |
| Thermal Resistance Junction-ambient (Steady State) ₁ | $R_{\theta JA}$ | 85 | $^\circ C/W$ |
| Thermal Resistance Junction Case ₁ | $R_{\theta JC}$ | 30 | $^\circ C/W$ |

*Drain current limited by maximum junction temperature

➤ Electrical Characteristics ($T_J=25^\circ C$ Unless otherwise noted)

| Parameter | Symbol | Conditions | Min. | Typ. | Max. | Unit |
|------------------------------------------------|--------------|------------------------------------------------|------|------|-----------|----------|
| Drain-Source Breakdown Voltage | BV_{DSS} | $V_{GS}=0V, I_D=250\mu A$ | 200 | --- | --- | V |
| Static Drain-Source On-Resistance ² | $R_{DS(ON)}$ | $V_{GS}=10V, I_D=1A$ | --- | 0.6 | 1.0 | Ω |
| | | $V_{GS}=4.5V, I_D=1A$ | --- | 0.7 | 1.1 | Ω |
| Gate Threshold Voltage | $V_{GS(th)}$ | $V_{GS}=V_{DS}, I_D=250\mu A$ | 1.2 | 2 | 3 | V |
| Drain-Source Leakage Current | I_{DSS} | $V_{DS}=200V, V_{GS}=0V, T_J=25^\circ C$ | --- | --- | 1 | μA |
| Gate-Source Leakage Current | I_{GSS} | $V_{GS}=\pm 20V, V_{DS}=0V$ | --- | --- | ± 100 | nA |
| Forward Transconductance | g_{fs} | $V_{DS}=10V, I_D=1A$ | --- | 10 | --- | S |
| Total Gate Charge (10V) | Q_g | $V_{DS}=160V, V_{GS}=10V, I_D=1A$ | --- | 15 | | nC |
| Gate-Source Charge | Q_{gs} | | --- | 3.0 | | |
| Gate-Drain Charge | Q_{gd} | | --- | 5.2 | | |
| Turn-On Delay Time | $T_{d(on)}$ | $V_{DD}=100V, V_{GS}=10V, R_G=3\Omega, I_D=1A$ | --- | 22 | | ns |
| Rise Time | T_r | | --- | 34 | | |
| Turn-Off Delay Time | $T_{d(off)}$ | | --- | 45 | | |
| Fall Time | T_f | | --- | 11 | | |
| Input Capacitance | C_{iss} | $V_{DS}=25V, V_{GS}=0V, F=1MHz$ | --- | 900 | | pF |
| Output Capacitance | C_{oss} | | --- | 130 | | |
| Reverse Transfer Capacitance | C_{rss} | | --- | 4.6 | | |

➤ Diode Characteristics

| Parameter | Symbol | Conditions | Min. | Typ. | Max. | Unit |
|------------------------------------------|----------|-------------------------------------|------|------|------|------|
| Continuous Source Current ^{1,6} | I_S | $V_G=V_D=0V$, Force Current | --- | --- | 1 | A |
| Diode Forward Voltage ² | V_{SD} | $V_{GS}=0V, I_S=1A, T_J=25^\circ C$ | --- | --- | 1 | V |
| Reverse Recovery Time | t_{rr} | $I_F=1A, di/dt=100A/\mu s,$ | --- | 85 | --- | nS |
| Reverse Recovery Charge | Q_{rr} | $T_J=25^\circ C$ | --- | 257 | --- | nC |

Note :

1. Pulse width limited by maximum junction temperature.
2. The data tested by pulsed, pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
3. The EAS data shows Max. rating. The test condition is $V_{DD}=50V, V_{GS}=10V, L=1mH, I_{AS}=4A$
4. Ensure that the channel temperature does not exceed $150^\circ C$.
5. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.

➤ Typical Characteristics

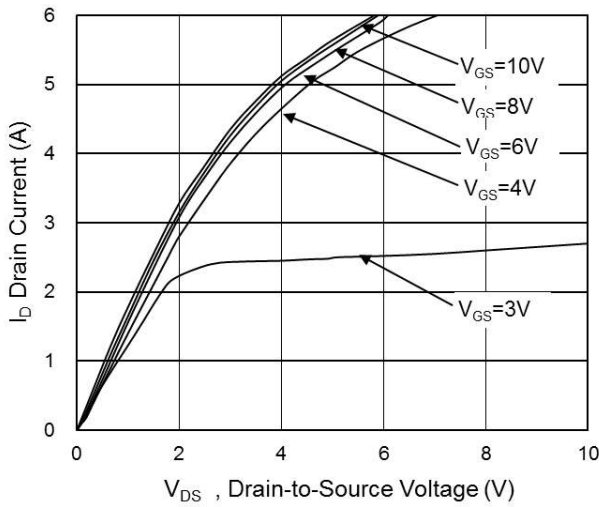


Fig.1 Typical Output Characteristics

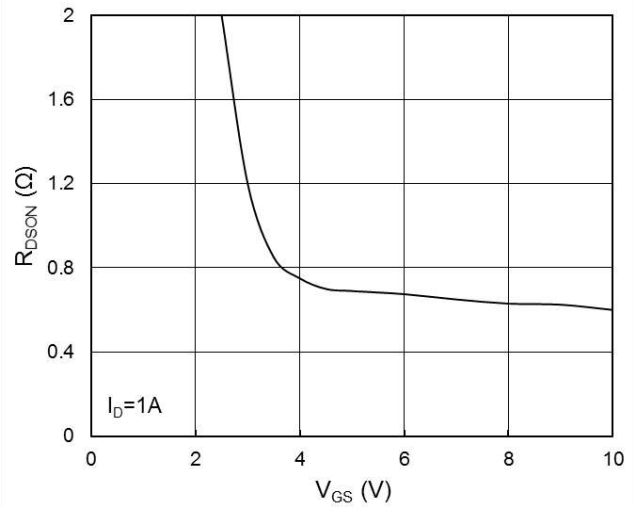


Fig.2 On-Resistance vs. G-S Voltage

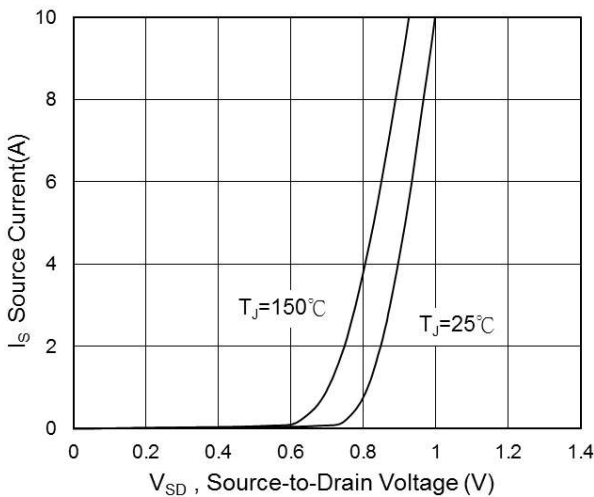


Fig.3 Forward Characteristics of Reverse

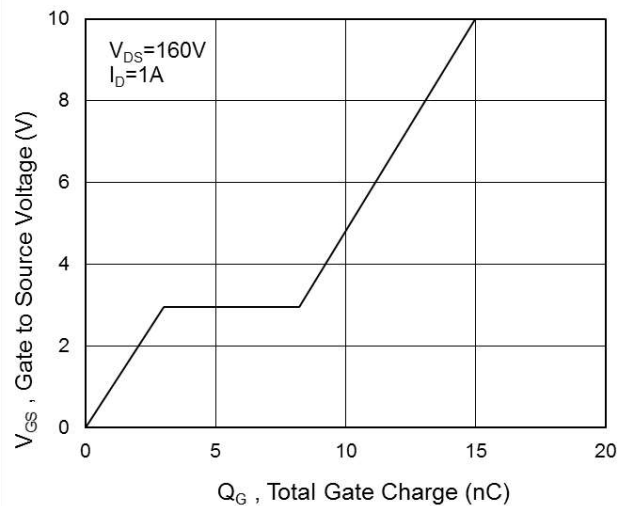


Fig.4 Gate-Charge Characteristics

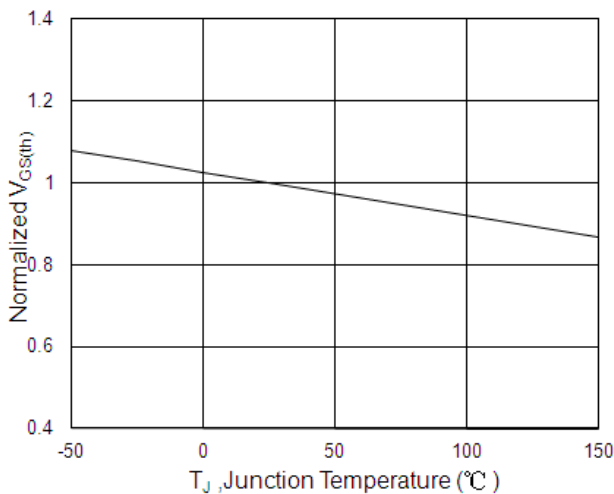


Fig.5 $V_{GS(th)}$ vs. T_J

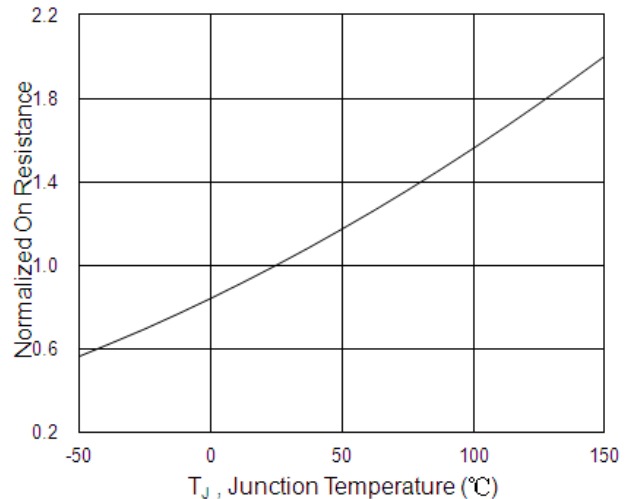


Fig.6 Normalized $R_{DS(ON)}$ vs. T_J

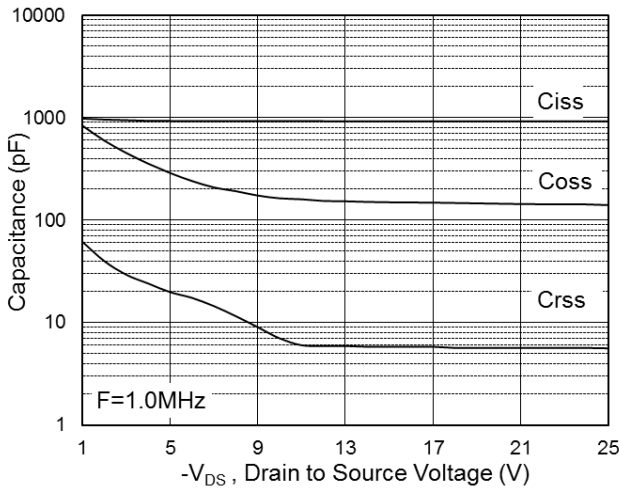


Fig.7 Capacitance

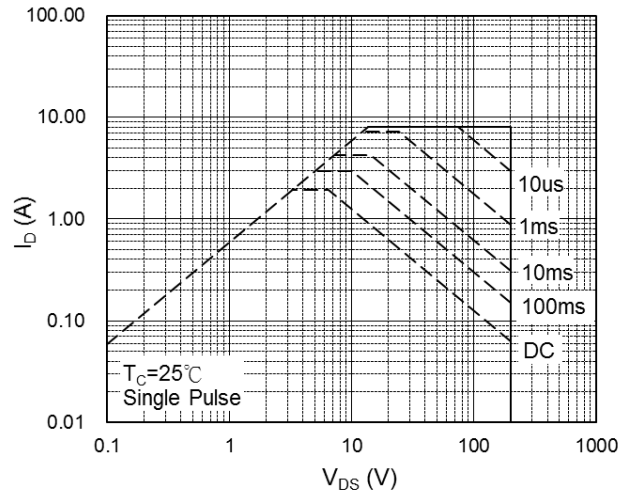


Fig.8 Safe Operating Area

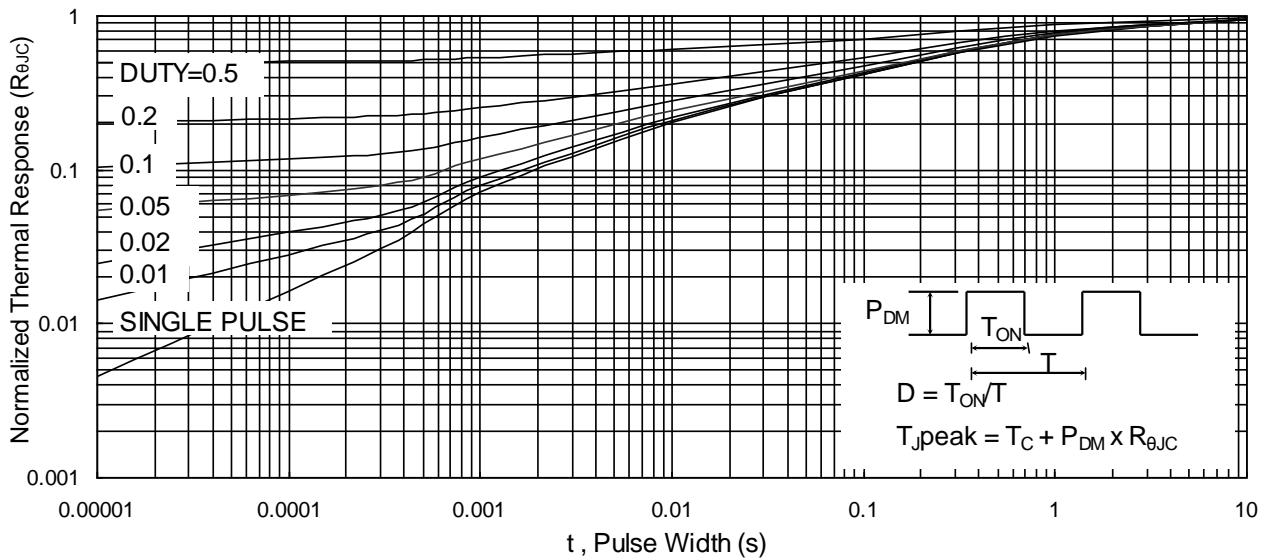


Fig.9 Normalized Maximum Transient Thermal Impedance

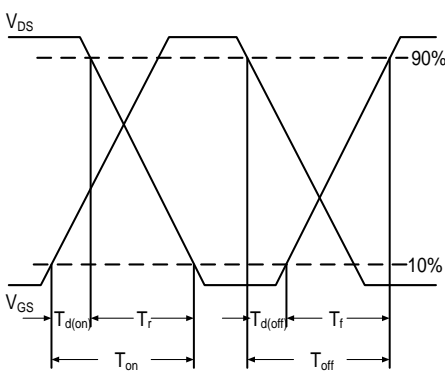


Fig.10 Switching Time Waveform

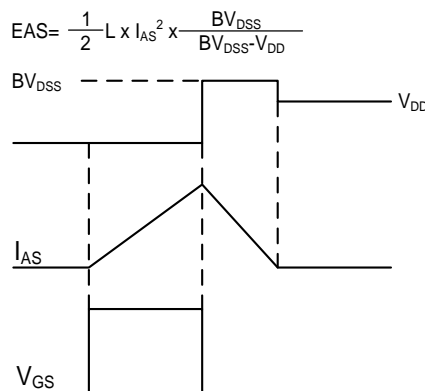


Fig.11 Unclamped Inductive Switching Waveform

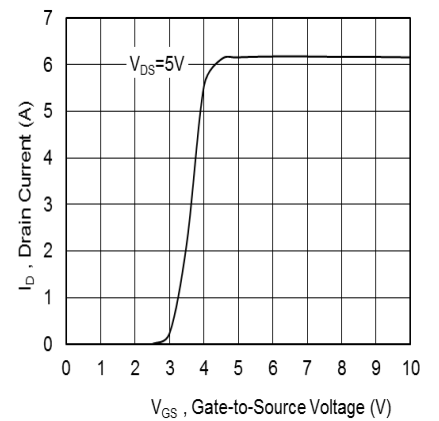


Fig.11 Transfer Characteristics

➤ Recommand IR Reflow Soldering Thermal Profile

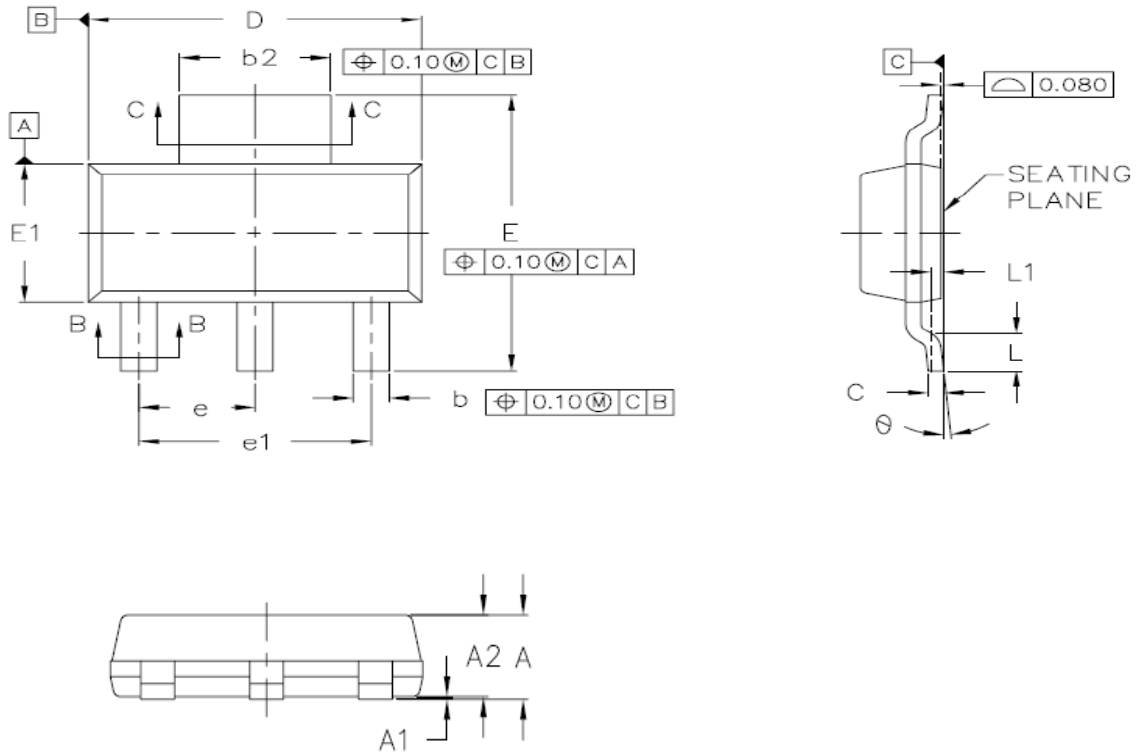


| Profile Feature | Pb-Free Assembly Profile |
|-----------------------------------------------------------------------|--------------------------|
| Temperature Min. (T _{smin}) | 150°C |
| Temperature Max. (T _{smax}) | 200°C |
| Time (t _s) from (T _{smin} to T _{smax}) | 60-120 seconds |
| Average Ramp-up Rate (t _L to t _P) | 3°C/second max. |
| Liquidous Temperature (T _L) | 217°C |
| Time (t _L) Maintained Above (T _L) | 60 – 150 seconds |
| Peak Temperature | 260°C +0°C / -5°C |
| Time (t _P) within 5°C of actual Peak Temperature | 30 seconds |
| Ramp-down Rate (T _P to T _L) | 6°C/second max |
| Time 25°C to Peak Temperature | 8 minutes max. |

➤ Ordering Information

| Part Number | Description | Quantity |
|-------------|--------------|----------|
| PAN03TB20QB | SOT-223 Reel | 3000 pcs |

➤ Package Information (SOT-223)



| DIMENSIONS | COMMON | | | |
|------------|-----------|------|------------|-------|
| | MM | | INCH | |
| | MIN. | MAX. | MIN. | MAX. |
| A | — | 1.80 | — | 0.071 |
| A1 | 0.02 | 0.10 | 0.001 | 0.004 |
| A2 | 1.50 | 1.70 | 0.059 | 0.067 |
| b | 0.66 | 0.84 | 0.026 | 0.033 |
| b1 | 0.60 | 0.79 | 0.024 | 0.031 |
| b2 | 2.90 | 3.10 | 0.114 | 0.122 |
| b3 | 2.84 | 3.05 | 0.112 | 0.120 |
| c | 0.23 | 0.35 | 0.009 | 0.014 |
| c1 | 0.23 | 0.33 | 0.009 | 0.013 |
| D | 6.30 | 6.70 | 0.248 | 0.264 |
| E | 6.70 | 7.30 | 0.264 | 0.287 |
| E1 | 3.30 | 3.70 | 0.130 | 0.146 |
| e | 2.30 BSC. | | 0.091 BSC. | |
| e1 | 4.60 BSC. | | 0.182 BSC. | |
| L | 0.81 | — | 0.032 | — |
| L1 | 0.25 BSC. | | 0.010 BSC. | |
| θ | 0° | 10° | 0° | 10° |

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